TOSHIBA Photocoupler Photorelay

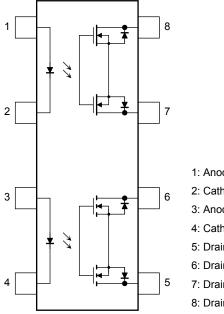
# **TLP4027G**

Telecommunication Measurement Equipment Security Equipment FA

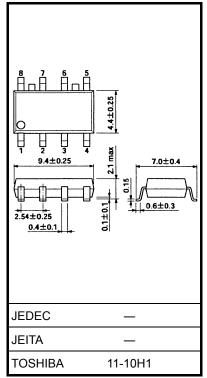
The Toshiba TLP4027G consists of an aluminum gallium arsenide infrared emitting diode optically coupled to a photo-MOSFET and is the 1-form-A/B photorelay with 350-V withstanding voltage.

- Normally closed (1-form-B) device, normally opened (1-form-A) device
- Peak off-state voltage: 350 V (min)
- Trigger LED current: 3 mA (max)
- On-state current: 90 mA (max)
- On-state resistance:  $50 \Omega$  (max)
- Isolation voltage: 1500 Vrms (min)
- UL Recognized: UL1577, File No. E67349

## Pin Configuration (top view)



1: Anode (1b) 2: Cathode (1b) 3: Anode (1a) 4: Cathode (1a) 5: Drain D1 (1a) 6: Drain D2 (1a) 7: Drain D3 (1b) 8: Drain D4 (1b)



Weight: 0.2 g (typ.)

Unit: mm

Absolute Maximum Ratings (Ta = 25°C)

	Charac	Symbol	Rating	Unit	
	Forward current		١ <sub>F</sub>	50	mA
LED	Forward current derating (Ta	∆I <sub>F</sub> /°C	-0.5	mA/°C	
	Peak forward current		I <sub>FP</sub>	1	А
	Reverse voltage	V <sub>R</sub>	5	V	
	Junction temperature		Tj	125	°C
	Off-state output terminal volt	V <sub>OFF</sub>	350	V	
		One channel operation			
Detector	On-state current	Two channel operations (1a1b simultaneous operation)	I <sub>ON</sub>	90	mA
Dete		One channel operation			
	On-state current derating (Ta ≧ 25°C)	Two channel operations (1a1b simultaneous operation)	∆l <sub>ON</sub> /°C	-0.9	mA/°C
	Junction temperature		Tj	125	°C
Stora	age temperature range	T <sub>stg</sub>	-55 to 125	°C	
Oper	rating temperature range	T <sub>opr</sub>	-40 to 85	°C	
Lead	soldering temperature (10 s)	T <sub>sol</sub>	260	°C	
Isola	tion voltage (AC, 1 min, R.H.	BVS	1500	Vrms	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Pins 1, 2, 3 and 4 are shorted together, and pins 5, 6, 7 and 8 are shorted together.

#### **Recommended Operating Conditions**

Characteristics	Symbol	Min	Тур.	Max	Unit
Supply voltage	V <sub>DD</sub>			280	V
Forward current	١ <sub>F</sub>	5	10	25	mA
On-state current	I <sub>ON</sub>			90	mA
Operating temperature	T <sub>opr</sub>	-20		65	°C

Note: Recommended operating conditions are given as a design guideline to obtain expected performance of the device. Additionally, each item is an independent guideline respectively. In developing designs using this product, please confirm specified characteristics shown in this document.

## Electrical Characteristics (Ta = 25°C)

	Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
	Forward voltage	VF	I <sub>F</sub> = 10 mA	1.0	1.15	1.3	V
LED	Reverse current	I <sub>R</sub>	$V_R = 5 V$	_	_	10	μA
	Capacitance	CT	V = 0, f = 1 MHz	_	30	_	pF
or	Off-state current	IOFF	V <sub>OFF</sub> = 350 V	_	_	1	μA
Detector	Capacitance (1b)	C	$V = 0, f = 1 \text{ MHz}, I_F = 5 \text{ mA}$		30		۶E
	Capacitance (1a)	C <sub>OFF</sub>	V = 0, f = 1 MHz		30		pF

# **Coupled Electrical Characteristics (Ta = 25°C)**

Characteristics	Form	Symbol	Test Condition	Min	Тур.	Max	Unit
Trigger LED current	1a	I <sub>FT</sub>	I <sub>ON</sub> = 90 mA	-	1	3	mA
	1b	I <sub>FC</sub>	$I_{OFF} = 10 \ \mu A$		1		iiiA
Return LED current	1a	I <sub>FC</sub>	I <sub>OFF</sub> = 10 μA	0.1			mA
	1b	I <sub>FT</sub>	I <sub>ON</sub> = 90 mA	0.1	_		III <del>A</del>
On-state resistance (Note 2)	_	R <sub>ON</sub>	I <sub>ON</sub> = 90 mA, t < 1s	_	27	35	Ω
			I <sub>ON</sub> = 90 mA	_	40	50	52

Note 2: 1-form-A:  $I_F = 5 \text{ mA}$ , 1-form-B:  $I_F = 0 \text{ mA}$ 

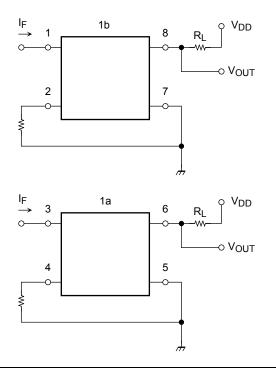
#### Isolation Characteristics (Ta = 25°C)

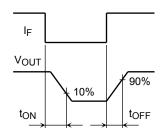
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Capacitance input to output	CS	$V_S = 0, f = 1 MHz$	—	0.8	—	pF
Isolation resistance	R <sub>S</sub>	$V_{S} = 500 \text{ V}, \text{ R.H.} \le 60\%$	$5  imes 10^{10}$	10 <sup>14</sup>	_	Ω
		AC, 1 min	1500	_	_	Vrms
Isolation voltage		AC, 1 s, in oil	—	3000	_	
		DC, 1 min, in oil	—	3000	_	Vdc

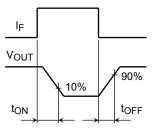
# Switching Characteristics (Ta = 25°C)

	Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
1b	Turn-on time	t <sub>ON</sub>	RL = 200 Ω	_	0.25	1	ms
10	Turn-off time	tOFF	$V_{DD} = 20 \text{ V}, \text{ I}_{\text{F}} = 5 \text{ mA}$ (Note 3)	_	0.5	1	1115
1a	Turn-on time	t <sub>ON</sub>	RL = 200 Ω	_	0.3	1	me
Ta	Turn-off time	tOFF	$V_{DD} = 20 \text{ V}, \text{ I}_{\text{F}} = 5 \text{ mA}$ (Note 3)	_	0.15	1	ms

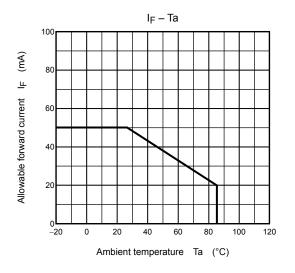
Note 3: Switching time test circuit

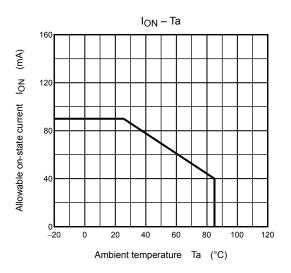


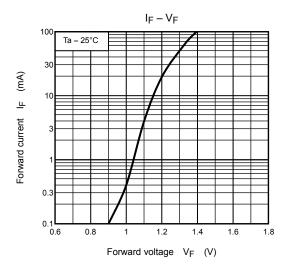




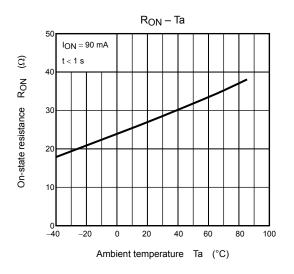
# Characteristics curves for 1-form-A/B

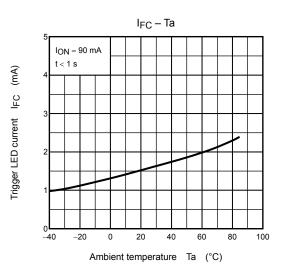


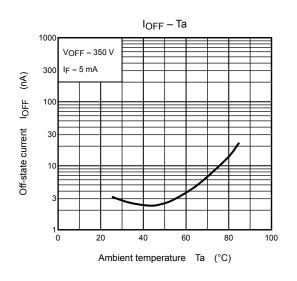


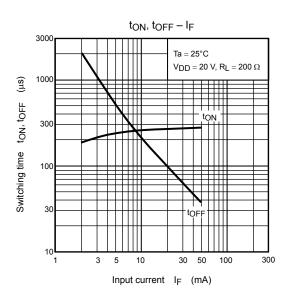


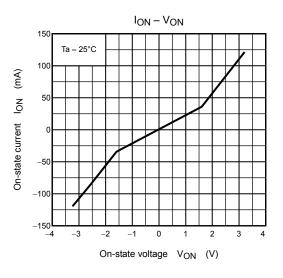
### Characteristics curves for 1-form-B

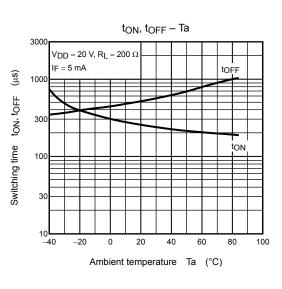




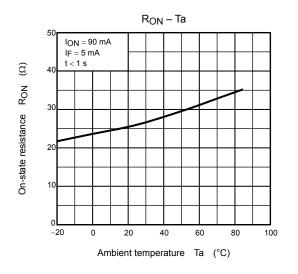


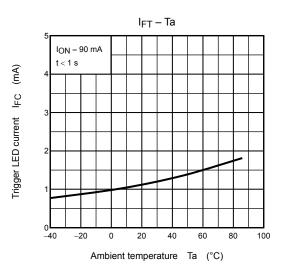


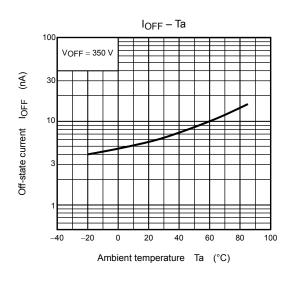


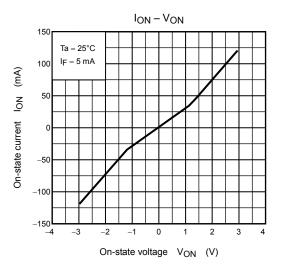


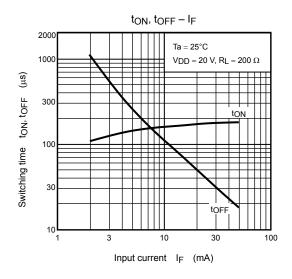
## Characteristics curves for 1-form-A

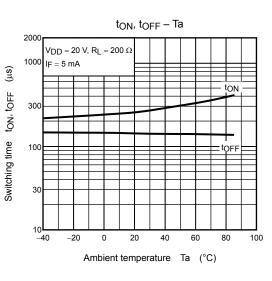












#### **RESTRICTIONS ON PRODUCT USE**

20070701-EN

- The information contained herein is subject to change without notice.
- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
  In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc.
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.).These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in his document shall be made at the customer's own risk.
- The products described in this document shall not be used or embedded to any downstream products of which manufacture, use and/or sale are prohibited under any applicable laws and regulations.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA for any infringements of patents or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any patents or other rights of TOSHIBA or the third parties.
- GaAs(Gallium Arsenide) is used in this product. The dust or vapor is harmful to the human body. Do not break, cut, crush or dissolve chemically.
- Please contact your sales representative for product-by-product details in this document regarding RoHS compatibility. Please use these products in this document in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled substances. Toshiba assumes no liability for damage or losses occurring as a result of noncompliance with applicable laws and regulations.